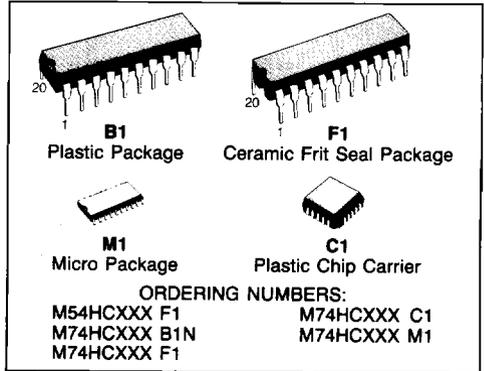




HC540 OCTAL BUS BUFFER INVERTING (3-STATE)
HC541 OCTAL BUS BUFFER (3-STATE)

- **HIGH SPEED**
 $t_{PD} = 11 \text{ ns (TYP.) at } V_{CC} = 5\text{V}$
- **LOW POWER DISSIPATION**
 $I_{CC} = 4 \mu\text{A (MAX.) at } T_A = 25^\circ\text{C}$
- **HIGH NOISE IMMUNITY**
 $V_{NIH} = V_{NIL} = 28\% V_{CC} \text{ (MIN.)}$
- **OUTPUT DRIVE CAPABILITY**
15 LSTTL LOADS
- **SYMMETRICAL OUTPUT IMPEDANCE**
 $|I_{OH}| = |I_{OL}| = 6 \text{ mA (MIN.)}$
- **BALANCED PROPAGATION DELAYS**
 $t_{PLH} = t_{PHL}$
- **WIDE OPERATING VOLTAGE RANGE**
 $V_{CC} \text{ (OPR)} = 2\text{V to } 6\text{V}$
- **PIN AND FUNCTION COMPATIBLE**
WITH 54/74LS540/541

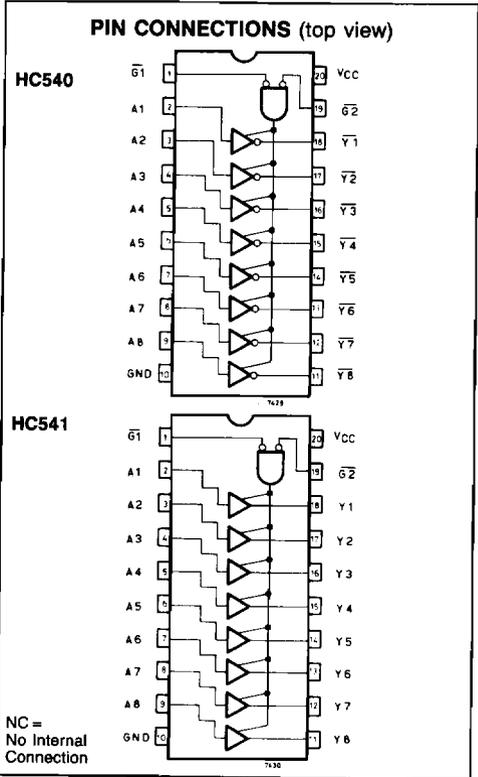
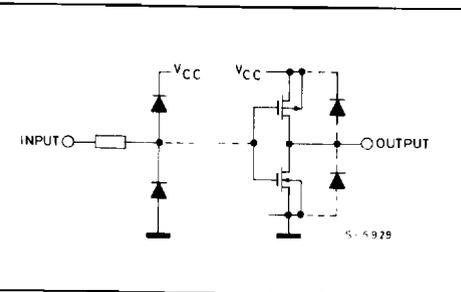


DESCRIPTION

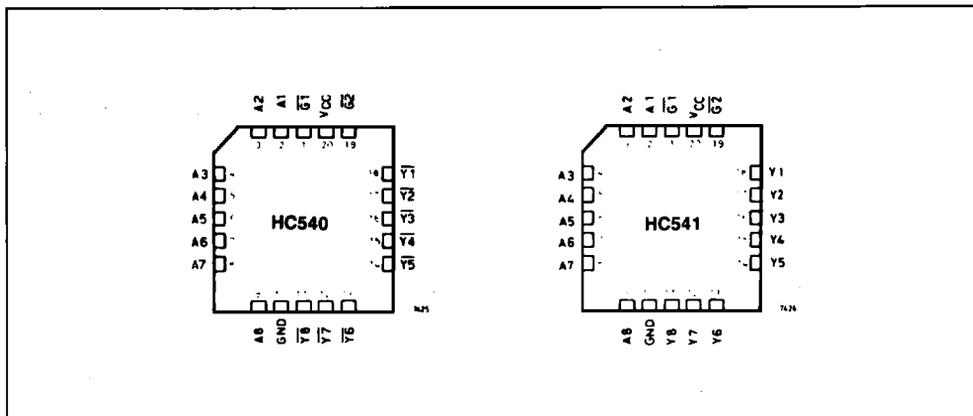
The M54/74HC540/541 are high speed CMOS OCTAL BUS BUFFERS (3-STATE) fabricated in silicon gate C²MOS technology. They have the same high speed performance of LSTTL combined with true CMOS low power consumption. The M54/74HC540 is an inverting buffer and the M54/74HC541 is a non-inverting buffer. The 3-STATE control gate operates as a two-input AND such that if either G1 or G2 are high, all eight outputs are in the high-impedance state. In order to enhance PC board layout, the 'HC540 and 'HC541 offers a pinout having inputs and outputs on opposite sides of the package.

All inputs are equipped with protection circuits against static discharge and transient excess voltage.

INPUT AND OUTPUT EQUIVALENT CIRCUIT



CHIP CARRIER

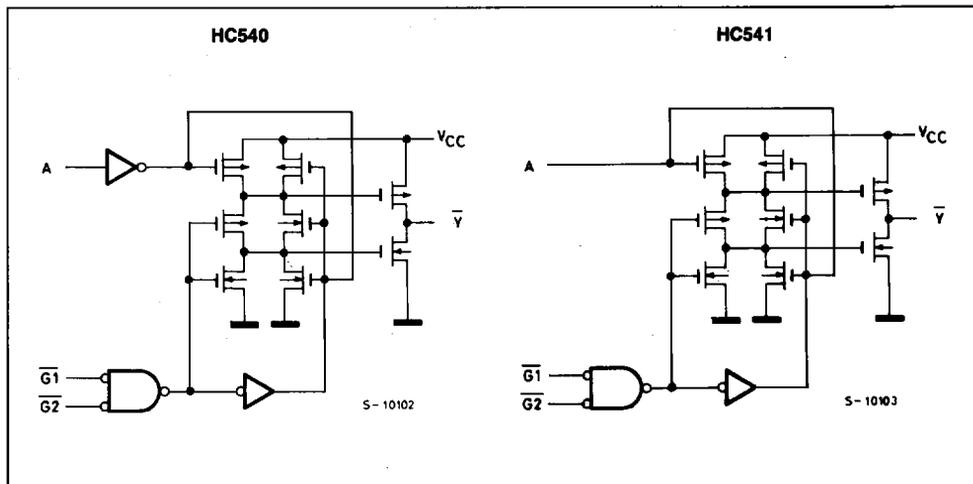


TRUTH TABLE

INPUTS			OUTPUT	
$\overline{G1}$	$\overline{G2}$	A_n	Y_n^*	\overline{Y}_n^*
H	X	X	Z	Z
X	H	X	Z	Z
L	L	H	L	L
L	L	L	L	H

X: DON'T CARE Z: HIGH IMPEDANCE
 *: Y_nHC541 \overline{Y}_nHC540

CIRCUIT DIAGRAM (Per Circuit)



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	-0.5 to 7	V
V_I	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
V_O	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
I_{IK}	DC Input Diode Current	± 20	mA
I_{OK}	DC Output Diode Current	± 20	mA
I_O	DC Output Source Sink Current Per Output Pin	± 35	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	± 70	mA
P_D	Power Dissipation	500 (*)	mW
T_{stg}	Storage Temperature	-65 to 150	$^{\circ}C$

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(*) 500 mW: $\cong 65^{\circ}C$ derate to 300 mW by 10 mW/ $^{\circ}C$: $65^{\circ}C$ to $85^{\circ}C$.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	2 to 6	V
V_I	Input Voltage	0 to V_{CC}	V
V_O	Output Voltage	0 to V_{CC}	V
T_A	Operating Temperature 74HC Series 54HC Series	-40 to 85 -55 to 125	$^{\circ}C$
t_r, t_f	Input Rise and Fall Time	$V_{CC} \begin{cases} 2 \text{ V} & 0 \text{ to } 1000 \\ 4.5 \text{ V} & 0 \text{ to } 500 \\ 6 \text{ V} & 0 \text{ to } 400 \end{cases}$	ns

DC SPECIFICATIONS

Symbol	Parameter	V_{CC}	Test Condition		$T_A = 25^{\circ}C$ 54HC and 74HC			$-40 \text{ to } 85^{\circ}C$ 74HC		$-55 \text{ to } 125^{\circ}C$ 54HC		Unit
					Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
V_{IH}	High Level Input Voltage	2.0			1.5	—	—	1.5	—	1.5	—	V
		4.5			3.15	—	—	3.15	—	3.15	—	
		6.0			4.2	—	—	4.2	—	4.2	—	
V_{IL}	Low Level Input Voltage	2.0			—	—	0.5	—	0.5	—	0.5	V
		4.5			—	—	1.35	—	1.35	—	1.35	
		6.0			—	—	1.8	—	1.8	—	1.8	
V_{OH}	High Level Output Voltage	2.0	V_I	I_O	1.9	2.0	—	1.9	—	1.9	—	V
		4.5			V_{IH} or V_{IL}	-20 μA	4.4	4.5	—	4.4	—	
		6.0			5.9	6.0	—	5.9	—	5.9	—	
		4.5	V_{IH} or V_{IL}	-4.0 mA	4.18	4.31	—	4.13	—	4.10	—	
		6.0		-5.2 mA	5.68	5.8	—	5.63	—	5.60	—	
		6.0										
V_{OL}	Low Level Output Voltage	2.0	V_{IH} or V_{IL}	20 μA	—	0.0	0.1	—	0.1	—	0.1	V
		4.5			—	0.0	0.1	—	0.1	—	0.1	
		6.0										
		4.5	V_{IH} or V_{IL}	4.0 mA	—	0.17	0.26	—	0.33	—	0.40	
		6.0		5.2 mA	—	0.18	0.26	—	0.33	—	0.40	
		6.0										

DC SPECIFICATIONS (Continued)

Symbol	Parameter	V _{CC}	Test Condition	T _A = 25°C 54HC and 74HC			- 40 to 85°C 74HC		- 55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
I _I	Input Leakage Current	6.0	V _I = V _{CC} or GND	—	—	±0.1	—	±1.0	—	±1.0	μA
I _{OZ}	3-State Output Off-State Current	6.0	V _I = V _{IH} or V _{IL} V _O = V _{CC} or GND	—	—	±0.5	—	±5.0	—	±10	μA
I _{CC}	Quiescent Supply Current	6.0	V _I = V _{CC} or GND	—	—	4	—	40	—	80	μA

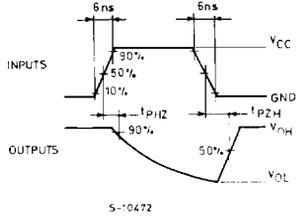
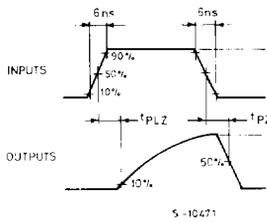
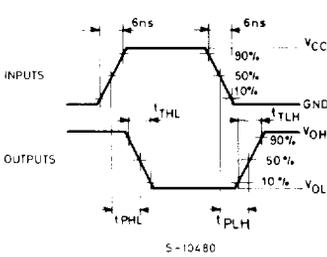
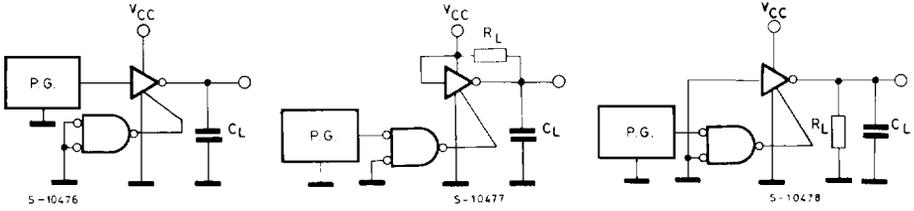
AC ELECTRICAL CHARACTERISTICS (C_L = 50pF, Input t_r = t_f = 6ns)

Symbol	Parameter	V _{CC}	Test Condition	T _A = 25°C 54HC and 74HC			- 40 to 85°C 74HC		- 55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t _{TLH} t _{THL}	Output Transition Time	2.0 4.5 6.0		— — —	25 7 6	60 12 10	— — —	75 15 13	— — —	90 18 15	ns
t _{PLH} t _{PHL}	Propagation Delay Time	2.0 4.5 6.0	HC540	— — —	52 13 11	105 21 18	— — —	130 26 22	— — —	160 32 27	ns
t _{PLH} t _{PHL}	Propagation Delay Time	2.0 4.5 6.0	HC541	— — —	56 14 12	15 23 20	— — —	145 29 25	— — —	135 35 30	ns
t _{PLZ} t _{PHZ}	3-State Output Enable	2.0 4.5 6.0	R _L = 1KΩ	— — —	72 18 15	145 29 25	— — —	180 36 31	— — —	220 44 38	ns
t _{PLZ} t _{PHZ}	3-State Output Disable Time	2.0 4.5 6.0	R _L = 1KΩ	— — —	88 22 19	160 32 27	— — —	200 40 34	— — —	240 48 41	ns
C _{IN}	Input Capacitance			—	5	10	—	10	—	10	pF
C _{OUT}	Output Capacitance			—	10	—	—	—	—	—	pF
C _{PD} (1)	Power Dissipation Capacitance		HC540	—	33	—	—	—	—	—	pF
			HC541	—	36	—	—	—	—	—	

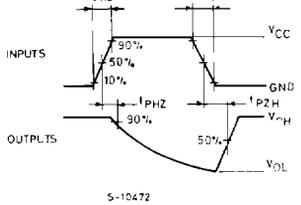
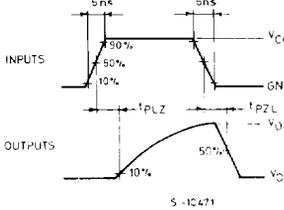
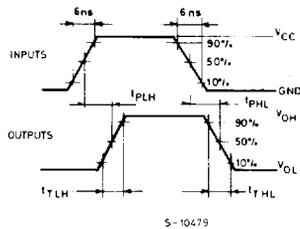
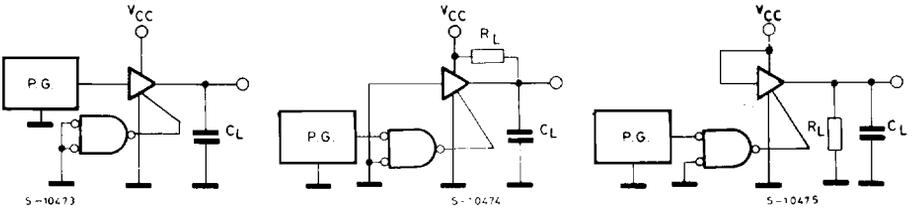
Note (1) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load.
 Average operating current can be obtained by the following equation.
 I_{CC(oper)} = C_{PD} · V_{CC} · f_{IN} + I_{CC}/8 (per Gate).

SWITCHING CHARACTERISTICS TEST CIRCUIT AND WAVEFORM

HC540



HC541



TEST CIRCUIT I_{CC} (Opr.)

